

MOSFET – Power, Single, N-Channel

80 V, 9.5 mΩ, 68 A

NVTFS6H850N

Features

- Small Footprint (3.3 x 3.3 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- NVTFS6H850NWF Wettable Flanks Product
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	80	V
Gate-to-Source Voltage	Э		V_{GS}	±20	V
Continuous Drain Current R _{0JC}	Steady State	$T_C = 25^{\circ}C$	I _D	68	Α
(Notes 1, 2, 3, 4)	Otato	$T_C = 100^{\circ}C$		48	
Power Dissipation	1	T _C = 25°C	P _D	107	W
$R_{\theta JC}$ (Notes 1, 2, 3)		T _C = 100°C		53	
Continuous Drain Current R _{0.IA}	Steady T _A = 25°C		I _D	11	Α
(Notes 1 & 3, 4)	State	T _A = 100°C		8.4	
Power Dissipation	1	T _A = 25°C		3.2	W
$R_{\theta JA}$ (Notes 1, 3)		T _A = 100°C		1.6	
Pulsed Drain Current	urrent $T_A = 25^{\circ}C$, $t_p = 10 \mu s$		I _{DM}	300	Α
Operating Junction and Storage Temperature			T _J , T _{stg}	–55 to +175	°C
Source Current (Body Diode)			I _S	89	Α
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 3.4 A)			E _{AS}	271	mJ
Lead Temperature for Soldering Purposes (1/8" from Case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

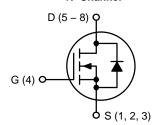
THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 3)	$R_{\theta JC}$	1.4	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	47	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Psi (Ψ) is used as required per JESD51–12 for packages in which substantially less than 100% of the heat flows to single case surface.
- 3. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- Continuous DC current rating. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
80 V	9.5 m Ω @ 10 V	68 A

N-Channel





WDFN8 3.3x3.3, 0.65P CASE 511AB



WDFNW8 3.3x3.3, 0.65P (Full-Cut μ8FL WF) CASE 515AN

MARKING DIAGRAM



XXXX = Specific Device Code A = Assembly Location

Y = Year
WW = Work Week
Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

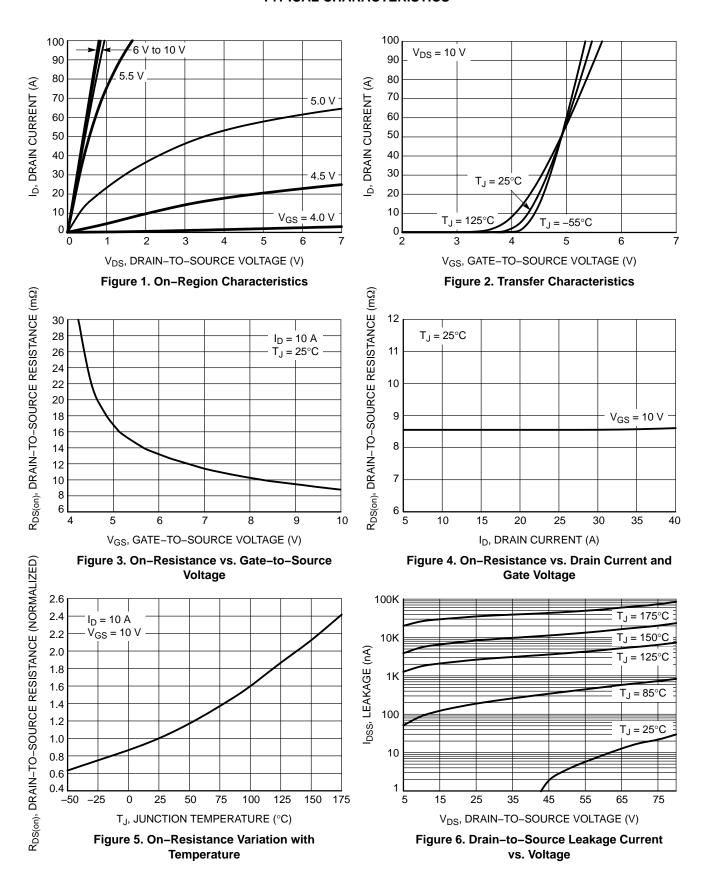
See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Cond	lition	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•	•			•	•	
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = 250 μA		80			V
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V$,	T _J = 25°C			10	μΑ
		V _{DS} = 80 V	T _J = 125°C			250	
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = 20$	V			100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 70$	μΑ	2.0		4.0	V
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D = 10	A		8.5	9.5	mΩ
Forward Transconductance	9FS	$V_{DS} = 15 \text{ V}, I_{D} = 10$	A		63		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{iss}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 40 V			1140		pF
Output Capacitance	C _{oss}				175		
Reverse Transfer Capacitance	C _{rss}				10		
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 10 V, V _{DS} = 40 V, I _D = 10 A			3.6		nC
Gate-to-Source Charge	Q _{GS}				6.5		1
Gate-to-Drain Charge	Q_{GD}				3.7		1
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = 10 \text{ V}, V_{DS} = 4$	10 V, I _D = 10 A		19		nC
SWITCHING CHARACTERISTICS (No	te 6)				•	•	
Turn-On Delay Time	t _{d(on)}	$V_{GS} = 6.0 \text{ V}, V_{DS} =$	64 V,		11		ns
Rise Time	t _r	I _D = 10 A			32		
Turn-Off Delay Time	t _{d(off)}				34		
Fall Time	t _f				8.0		1
DRAIN-SOURCE DIODE CHARACTER	RISTICS				•	•	
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 V$	$T_J = 25^{\circ}C$		0.8	1.2	V
		I _S = 10 A	T _J = 125°C		0.7		1
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V}, \text{ dI}_S/\text{dt} = 0$	I00 A/μs,		40		ns
Charge Time	t _a	I _S = 10 A			24		
Discharge Time	t _b				16		
Reverse Recovery Charge	Q _{RR}				40		nC

^{5.} Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

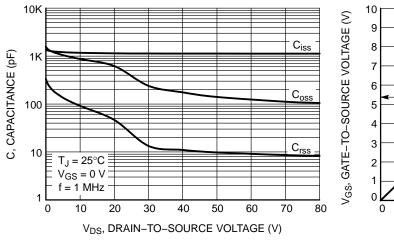


Figure 7. Capacitance Variation

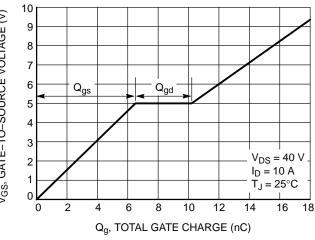


Figure 8. Gate-to-Source vs. Total Charge

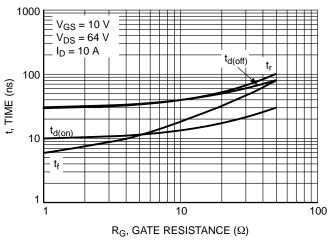


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

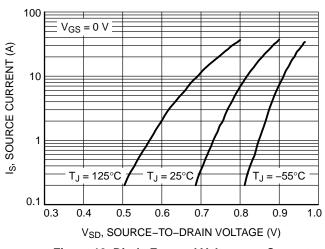


Figure 10. Diode Forward Voltage vs. Current

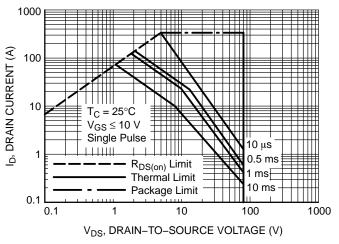


Figure 11. Maximum Rated Forward Biased Safe Operating Area

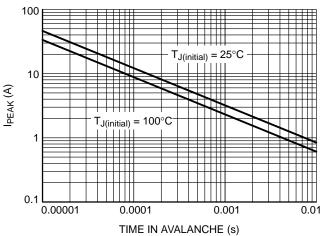


Figure 12. Maximum Drain Current vs. Time in Avalanche

TYPICAL CHARACTERISTICS

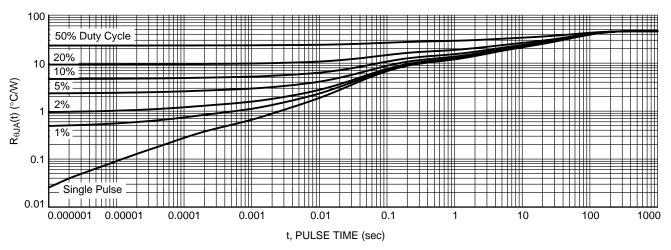


Figure 13. Thermal Response

DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NVTFS6H850NTAG	850N	WDFN8 3.3x3.3, 0.65P (Pb-Free)	1500 / Tape & Reel
NVTFS6H850NWFTAG	50NW	WDFNW8 3.3x3.3, 0.65P (Full-Cut μ8FL WF) (Pb-Free, Wettable Flanks)	1500 / Tape & Reel

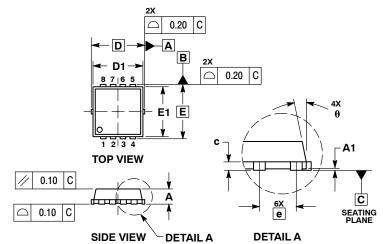
[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.





WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D

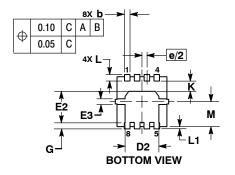
DATE 23 APR 2012



NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETERS.
 DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH
 PROTRUSIONS OR GATE BURRS.

	MILLIMETERS				INCHES	
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.70	0.75	0.80	0.028	0.030	0.031
A1	0.00		0.05	0.000		0.002
b	0.23	0.30	0.40	0.009	0.012	0.016
С	0.15	0.20	0.25	0.006	0.008	0.010
D		3.30 BSC		0	.130 BSC	;
D1	2.95	3.05	3.15	0.116	0.120	0.124
D2	1.98	2.11	2.24	0.078	0.083	0.088
E	3.30 BSC			0.130 BSC		
E1	2.95	3.05	3.15	0.116	0.120	0.124
E2	1.47	1.60	1.73	0.058	0.063	0.068
E3	0.23	0.30	0.40	0.009	0.012	0.016
е		0.65 BSC	;	(0.026 BS	0
G	0.30	0.41	0.51	0.012	0.016	0.020
K	0.65	0.80	0.95	0.026	0.032	0.037
L	0.30	0.43	0.56	0.012	0.017	0.022
L1	0.06	0.13	0.20	0.002	0.005	0.008
М	1.40	1.50	1.60	0.055	0.059	0.063
θ	0 °		12 °	0 °		12 °

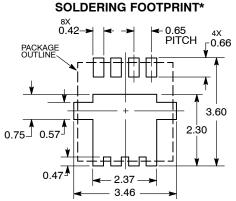


GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code = Assembly Location

= Year WW = Work Week = Pb-Free Package



DIMENSION: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

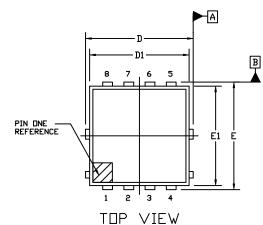
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DESCRIPTION:	WDFN8 3.3X3.3, 0.65P		PAGE 1 OF 1	

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^{*}This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.



DATE 25 AUG 2020



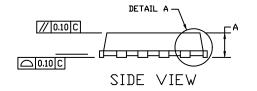


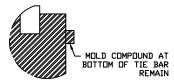
NDTES:

- 1. DIMENSIONING AND TOLERANCING PERASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- DIMENSION D1 AND E1 D0 NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.

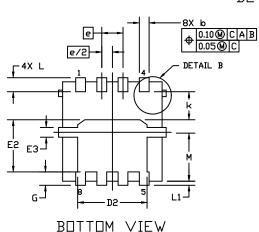
	PLATED AREA
DETAIL	C C SEATING PLANE

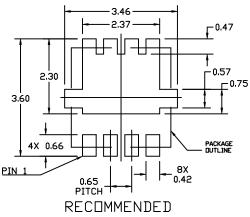
	MILLIMETERS			
DIM	MIN.	NDM.	MAX.	
A	0.70	0.75	0.80	
A1	0.00		0.05	
ø	0.23	0.30	0.40	
n	0.15	0.20	0.25	
D	3.05	3.30	3.55	
D1	2.95	3.05	3.15	
D2	1.98	2.11	2.24	
Ε	3.05	3.30	3.55	
E1	2.95	3.05	3.15	
E2	1.47	1.60	1.73	
E3	0.23	0.30	0.40	
a		0.65 BSC		
G	0.30	0.41	0.51	
K	0.65	0.80	0.95	
٦	0.30	0.43	0.59	
L1	0.06	0.13	0.20	
М	1.40	1.50	1.60	





DETAIL B





MOUNTING FOOTPRINT

For additional information on our Pb-Free strategy and soldering details, please download the DN Semiconductor Soldering and Mounting Techniques Reference Manual, SDLDERRM/D.

GENERIC MARKING DIAGRAM*



XXXX = Specific Device Code

A = Assembly Location

Y = Year

WW = Work Week

= Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

(Note: Microdot may be in either location)

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